

**Search Notes**

Application/Control No.

10/714,287

Examiner

TUYEN T. NGUYEN

Applicant(s)/Patent under  
Reexamination

MHEEN ET AL.

Art Unit

2832

**SEARCHED**

Class	Subclass	Date	Examiner
336	180-183, 192, 200, 232	7/6/2005	TTN
257	531	7/6/2005	TTN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
same as above		7/6/2005	TTN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR